

N-Channel Enhancement Mode Field Effect Transistor NDT3055

General Description

These N-Channel enhancement mode power field effect transistors are produced using **onsemi**'s proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance and provide superior switching performance. These devices are particularly suited for low voltage applications such as DC motor control and DC/DC conversion where fast switching, low in-line power loss, and resistance to transients are needed.

Features

- 4 A, 60 V
 - $R_{DS(ON)} = 0.100 \Omega @ V_{GS} = 10 V$
- High Density Cell Design for Extremely Low R_{DS(ON)}
- High Power and Current Handling Capability in a Widely Used Surface Mount Package
- This is a Pb-Free Device

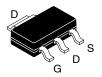
ABSOLUTE MAXIMUM RATINGS ($T_A = 25$ °C, unless otherwise noted)

Symbol	Parameter	Value	Unit
V_{DSS}	Drain-Source Voltage	60	V
V _{GSS}	Gate-Source Voltage	±20	V
I _D	Drain Current		Α
	Continuous (Note 1a)	4	
	- Pulsed	25	
P_{D}	Maximum Power Dissipation		W
	(Note 1a)	3	
	(Note 1b)	1.3	
	(Note 1c)	1.1	
T _J , T _{STG}	Operating and Storage Temperature Range	-65 to 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS (T_A = 25°C, unless otherwise noted)

Symbol	Parameter	Max	Unit
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	42	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	12	°C/W



SOT-223 CASE 318H-01

MARKING DIAGRAM



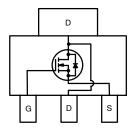
A = Assembly Location

Y = Year W = Work Week

3055 = Specific Device Code ■ Pb–Free Package

(Note: Microdot may be in either location)

PINOUT DIAGRAM



ORDERING INFORMATION

Device	Package	Shipping [†]
NDT3055	SOT-223 (Pb-Free)	4000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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ELECTRICAL CHARACTERISTICS ($T_A = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
OFF CHARA	CTERISTICS	•				
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60	-	_	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C	-	63	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 48 V, V _{GS} = 0 V	-	_	10	μΑ
		V _{DS} = 48 V, V _{GS} = 0 V, T _J = 125°C	-	_	100	
I _{GSSF}	Gate-Body Leakage, Forward	V _{GS} = 20 V, V _{DS} = 0 V	-	_	100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	V _{GS} = -20 V, V _{DS} = 0 V	-	_	-100	nA
ON CHARAC	CTERISTICS (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	3	4	V
		$V_{DS} = V_{GS}$, $I_D = 250 \mu A$, $T_J = 125^{\circ} C$	1.5	2.4	3	1
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 4 A	_	0.084	0.1	Ω
		$V_{GS} = 10 \text{ V}, I_D = 4 \text{ A}, T_J = 125^{\circ}\text{C}$	_	0.14	0.18	
I _{D(ON)}	On-State Drain Current	V _{GS} = 10 V, V _{DS} = 10 V	15	_	_	Α
9 _{FS}	Forward Transconductance	V _{DS} = 15 V, I _D = 4 A	_	6	_	S
YNAMIC C	HARACTERISTICS					
C _{iss}	Input Capacitance	V _{DS} = 30 V, V _{GS} = 0 V, f = 1.0 MHz	_	250	_	pF
C _{oss}	Output Capacitance		-	100	_	pF
C _{rss}	Reverse Transfer Capacitance		_	30	_	pF
WITCHING	CHARACTERISTICS (Note 2)					
t _{d(on)}	Turn - On Delay Time	V _{DD} = 25 V, I _D = 1.2 A,	-	10	25	ns
t _r	Turn – On Rise Time	V_{GS} = 10 V, R_{GEN} = 50 Ω	-	18	50	ns
t _{d(off)}	Turn - Off Delay Time		-	37	65	ns
t _f	Turn – Off Fall Time		-	30	60	ns
Qg	Total Gate Charge	V _{DS} = 40 V, I _D = 4 A, V _{GS} = 10 V	-	9	15	nC
Q_{gs}	Gate-Source Charge		-	2.3	-	nC
Q_{gd}	Gate-Drain Charge		-	2.6	-	nC
RAIN-SOU	RCE DIODE CHARACTERISTICS AND MA	XIMUM RATINGS				
IS	Maximum Continuous Drain-Source Diod	e Forward Current	_	_	2.5	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.5 A (Note 2)	_	0.85	1.2	V
	-	3	-			

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

R_{θJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{θJC} is guaranteed by design while R_{θCA} is determined by the user's board design.
 Typical R_{θJA} using the board layouts shown below on FR-4 PCB in a still air environment:



a. 42° C/W when mounted on a 1 in² pad of 2 oz copper.



b. 95°C/W when mounted on a 0.066 in² pad of 2 oz copper.



c. 110°C/W when mounted on a 0.00123 in² pad of 2 oz Cu..

2. Pulse Test: Pulse Width \leq 300 $\mu s,$ Duty Cycle \leq 2.0%.

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TYPICAL ELECTRICAL CHARACTERISTICS

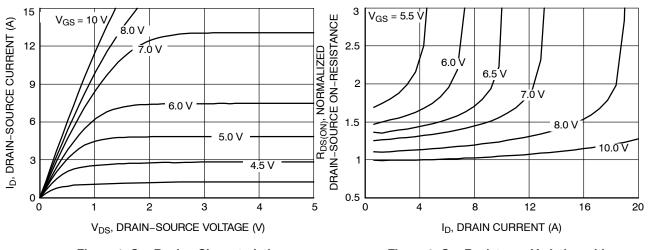


Figure 1. On-Region Characteristics

Figure 2. On–Resistance Variation with Drain Current and Gate Voltage

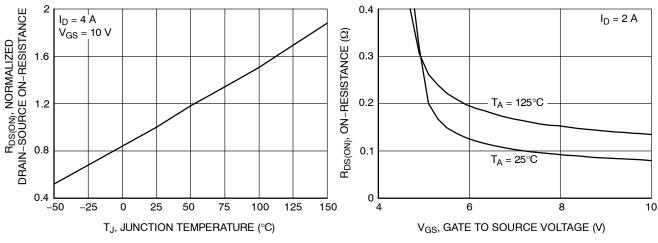


Figure 3. On–Resistance Variation with Temperature

Figure 4. On–Resistance Variation with Gate–to–Source Voltage

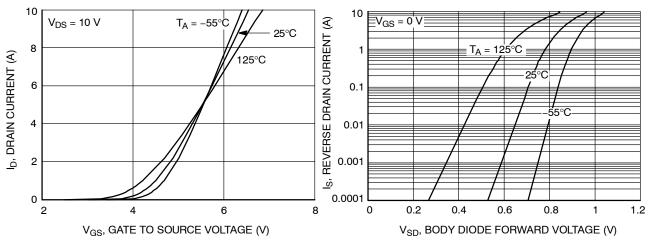
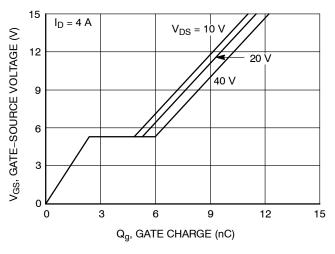


Figure 5. Transfer Characteristics

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

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TYPICAL ELECTRICAL CHARACTERISTICS (continued)



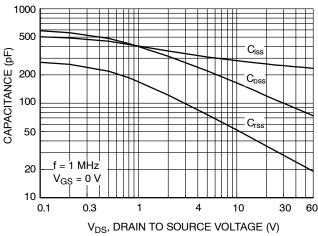
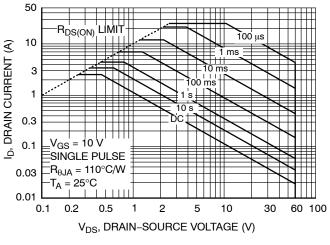


Figure 7. Gate Charge Characteristics

Figure 8. Capacitance Characteristics



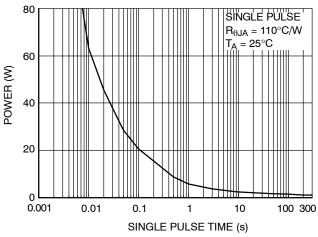


Figure 9. Maximum Safe Operating Area

Figure 10. Single Pulse Maximum Power Dissipation

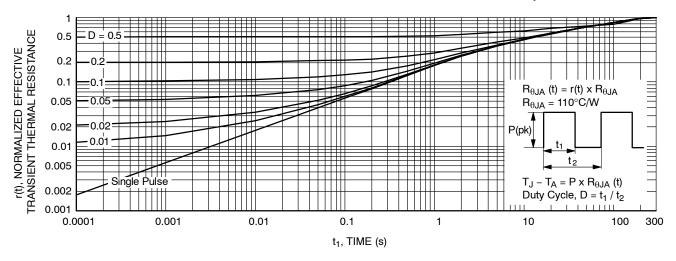


Figure 11. Transient Thermal Response Curve

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

SCALE 2:1



A

В

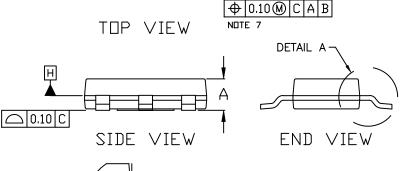
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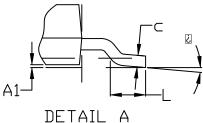
NOTES

- DIMENSIONING AND TOLERANCING PER ASME
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 Y14.5M, 2009.
 CONTROLLING DIMENSION: MILLIMETERS
 DIMENSIONS D & E1 ARE DETERMINED AT DATUM
 H. DIMENSIONS DO NOT INCLUDE MOLD FLASH,
 PROTRUSIONS DR GATE BURRS. SHALL NOT
 EXCEED 0.23mm PER SIDE.
 LEAD DIMENSIONS & AND &1 DO NOT INCLUDE
 DAMBAR PROTRUSION. ALLOWABLE DAMBBAR
 PROTRUSION IS 0.08mm PER SIDE.
 DATUMS A AND B ARE DETERMINED AT DATUM H.
 A1 IS DEFINED AS THE VERTICAL DISTANCE
 FROM THE SEATING PLANE TO THE LOWEST
 POINT OF THE PACKAGE BODY.
 POSITIONAL TOLERANCE APPLIES TO DIMENSIONS
 & AND &1.

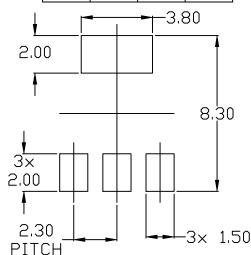
- b AND b1.

	MILLIMETERS			
DIM	MIN.	N□M.	MAX.	
Α			1.80	
A1	0.02	0.06	0.11	
b	0.60	0.74	0.88	
b1	2.90	3.00	3.10	
c	0.24		0.35	
D	6.30	6.50	6.70	
E	6.70	7.00	7.30	
E1	3.30	3.50	3.70	
е	2.30 BSC			
L	0.25			
Ż	0*		10°	









GENERIC MARKING DIAGRAM*

AYW

XXXXX.

= Assembly Location

= Year = Work Week **W**

XXXXX = Specific Device Code

= Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the IIN Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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